



Modified Form PTO/SB/08A

Substitute for form 1449A/PTO

**INFORMATION DISCLOSURE  
STATEMENT BY APPLICANT**

(use as many sheets as necessary)

Sheet 1 of 2

*Complete If Known*

Application Number	09/189,761
Filing Date	November 11, 1998
First Named Inventor	Benjamin N. Eldridge et al.
Group Art Unit	2841 2827
Examiner Name	K. Cuneo
Attorney Docket No.	P71-US

**U.S. PATENT DOCUMENTS**

Examiner Initials*	Cite No. <sup>1</sup>	U.S. Patent Document		Name of Patentee or Applicant	Publication Date	Relevant Portions
		Number	Kind Code <sup>2</sup>			
[Handwritten vertical line]	1.	3881799		Elliott et al.	5/6/1975	
	2.	4553192		Babuka et al	11/12/1985	
	3.	4636722		Ardezzone	1/1/1987	
	4.	5090118		Kwon et al.	2/25/1992	
	5.	5092782 ~		Beaman	3/3/1992	
	6.	5103557		Leedy	4/14/1992	
	7.	5109596		Driller et al.	5/5/1992	
	8.	5172050		Swapp	12/15/92	
	9.	5177438		Littlebury et al.	1/5/1993	
	10.	5191708		Kasukabe et al.	3/9/1993	
	11.	5228861		Grabbe	7/20/1993	
	12.	5462440		Rothenberger	10/31/1995	
	13.	5465611		Ruf et al.	11/14/1995	
	14.	5476818		Yanof et al.	12/19/1995	
	15.	5555422		Nakano	9/10/1996	
	16.	5599194		Ozawa et al.	2/4/1997	
	17.	5625297		Arnaudov et al.	4/29/1997	
	18.	5632631		Fjelstad et al.	5/27/1997	
	19.	5723894		Ueno et al.	3/3/1998	
	20.	5829128		Eldridge et al.	11/3/1998	
	21.	5917707		Khandros et al.	6/29/1999	
	22.	5974662		Eldridge et al.	11/2/1999	
	23.	6002266		Briggs et al.	12/14/1999	
	24.	6031282		Jones et al	2/29/2000	
	25.	6059982		Palagonia et al.	5/9/2000	
	26.	6110823		Eldridge et al.	8/29/2000	
	27.	6114221		Tonti et al.	9/5/2000	
	28.	6184699		Smith et al.	2/6/2001	

Examiner Signature	[Handwritten Signature]	Date Considered	5/19/02
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EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication

<sup>1</sup>Unique citation designation number. <sup>2</sup>See attached Kinds of U.S. Patent Documents. <sup>3</sup>Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). <sup>4</sup>For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. <sup>5</sup>Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. <sup>6</sup>Applicant is to place a check mark here if English language Translation is attached.



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Attorney Docket No.	P71-US

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**FOREIGN PATENT DOCUMENTS**

Examiner Initials*	Cite No. <sup>1</sup>	Foreign Patent Document			Name of Patentee or Applicant	Publication Date	Relevant Portions	T <sup>6</sup>
		Office <sup>3</sup>	Number <sup>4</sup>	Kind Code <sup>5</sup>				
he	29	FR	2587549		Ayel	3/20/1987		
	30	JP	618555		Tetsuo	1/25/1994		
	31	JP	4214650		Shoichi	8/5/1992		
	32	JP	6119770		Sugino	2/5/1986		
	33	JP	7333232		Takayuki et al.	12/22/1995		
	34	JP	62160373		Mizumo et al.	10/12/1987		
	35	WO	9743653		Khandros et al.	11/20/1997		
	36	WO	9744676		Khandros et al.	11/27/1997		
✓	37	WO	9852224		Khandros et al.	11/19/1998		

**OTHER PRIOR ART - NONPATENT LITERATURE DOCUMENTS**

Examiner Initials*	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published	T <sup>2</sup>
he	38	KONG et al., "Integrated Electrostatically Resonant Scan Tip For An Atomic Force Microscope," Journal of Vacuum Science & Technology, Vol. B 11(3) No. 3, pp. 634-641 (May/June 1993)	
he	39	LEUNG et al., "Active Substrate Membrane Probe Card," Technical Digest of the International Electron Devices Meeting (IEDM) (October 12, 1995), pp. 709-712	

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				Group Art Unit	2841
				Examiner Name	K. Cuneo
Sheet	1	of	1	Attorney Docket No.	P71-US

## U.S. PATENT DOCUMENTS

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## FOREIGN PATENT DOCUMENTS

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